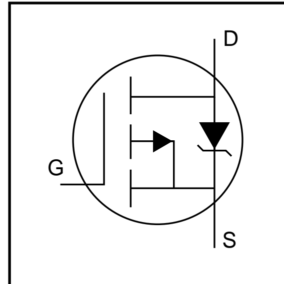
International
IOR Rectifier

PD - 9.1610B

IRFR/U5505

HEXFET® Power MOSFET

- Ultra Low On-Resistance
- P-Channel
- Surface Mount (IRFR5505)
- Straight Lead (IRFU5505)
- Advanced Process Technology
- Fast Switching
- Fully Avalanche Rated



V_{DSS} = -55V

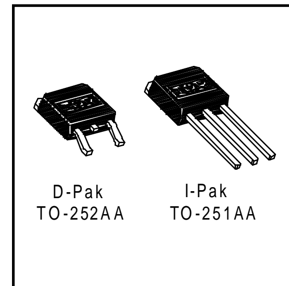
$R_{DS(on)}$ = 0.11Ω

I_D = -18A

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D-Pak is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 watts are possible in typical surface mount applications.



Absolute Maximum Ratings

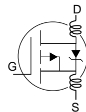
	Parameter	Max.	Units
I_D @ T_C = 25°C	Continuous Drain Current, V_{GS} @ -10V	-18	A
I_D @ T_C = 100°C	Continuous Drain Current, V_{GS} @ -10V	-11	
I_{DM}	Pulsed Drain Current ①	-64	
P_D @T_C = 25°C	Power Dissipation	57	W
	Linear Derating Factor	0.45	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy②	150	mJ
I_{AR}	Avalanche Current①	-9.6	A
E_{AR}	Repetitive Avalanche Energy①	5.7	mJ
dv/dt	Peak Diode Recovery dv/dt ③	-5.0	V/ns
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to + 150	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

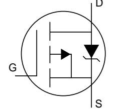
	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	——	2.2	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB mount)**	——	50	
$R_{\theta JA}$	Junction-to-Ambient	——	110	

8/25/97

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-55	——	——	V	V_{GS} = 0V, I_D = -250μA
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	——	-0.049	——	V/°C	Reference to 25°C, I_D = -1mA
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	——	——	0.11	Ω	V_{GS} = -10V, I_D = -9.6A ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0	——	-4.0	V	V_{DS} = V_{GS}, I_D = -250μA
g_{fs}	Forward Transconductance	4.2	——	——	S	V_{DS} = -25V, I_D = -9.6A
I_{DSS}	Drain-to-Source Leakage Current	——	——	-25	μA	V_{DS} = -55V, V_{GS} = 0V
		——	——	-250		V_{DS} = -44V, V_{GS} = 0V, T_J = 150°C
I_{GSS}	Gate-to-Source Forward Leakage	——	——	-100	nA	V_{GS} = 20V
	Gate-to-Source Reverse Leakage	——	——	100		V_{GS} = -20V
Q_g	Total Gate Charge	——	——	32	nC	I_D = -9.6A
Q_{gs}	Gate-to-Source Charge	——	——	7.1		V_{DS} = -44V
Q_{gd}	Gate-to-Drain ("Miller") Charge	——	——	15		V_{GS} = -10V, See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	——	12	——	ns	V_{DD} = -28V
t_r	Rise Time	——	28	——		I_D = -9.6A
$t_{d(off)}$	Turn-Off Delay Time	——	20	——		R_G = 2.6Ω
t_f	Fall Time	——	16	——		R_D = 2.8Ω, See Fig. 10 ④
L_D	Internal Drain Inductance	——	4.5	——	nH	Between lead, 6mm (0.25in.) from package
L_S	Internal Source Inductance	——	7.5	——		and center of die contact⑤ 
C_{iss}	Input Capacitance	——	650	——	pF	V_{GS} = 0V
C_{oss}	Output Capacitance	——	270	——		V_{DS} = -25V
C_{rss}	Reverse Transfer Capacitance	——	120	——		f = 1.0MHz, See Fig. 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	——	——	-18	A	MOSFET symbol showing the
I_{SM}	Pulsed Source Current (Body Diode) ①	——	——	-64		integral reverse p-n junction diode. 
V_{SD}	Diode Forward Voltage	——	——	-1.6	V	T_J = 25°C, I_S = -9.6A, V_{GS} = 0V ④
t_{rr}	Reverse Recovery Time	——	51	77	ns	T_J = 25°C, I_F = -9.6A
Q_{rr}	Reverse RecoveryCharge	——	110	160	nC	di/dt = 100A/μs ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

② Starting T_J = 25°C, L = 3.2mH R_G = 25Ω, I_{AS} = -9.6A. (See Figure 12)

③ I_{SD} ≤ -9.6A, di/dt ≤ 290A/μs, V_{DD} ≤ $V_{(BR)DSS}$, T_J ≤ 150°C

④ Pulse width ≤ 300μs; duty cycle ≤ 2%.

⑤This is applied for I-PAK, L_S of D-PAK is measured between lead and center of die contact

** When mounted on 1" square PCB (FR-4 or G-10 Material) .
For recommended footprint and soldering techniques refer to application note #AN-994

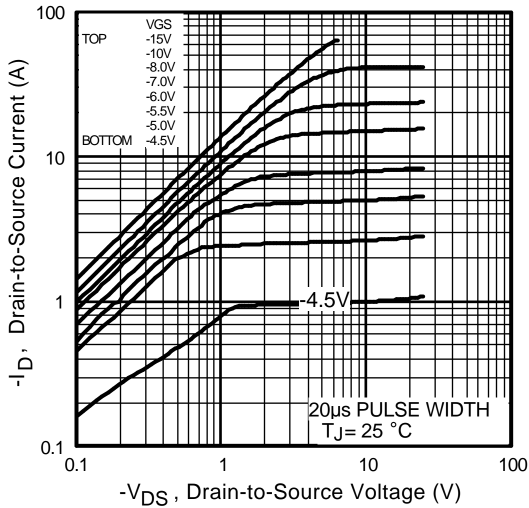


Fig 1. Typical Output Characteristics

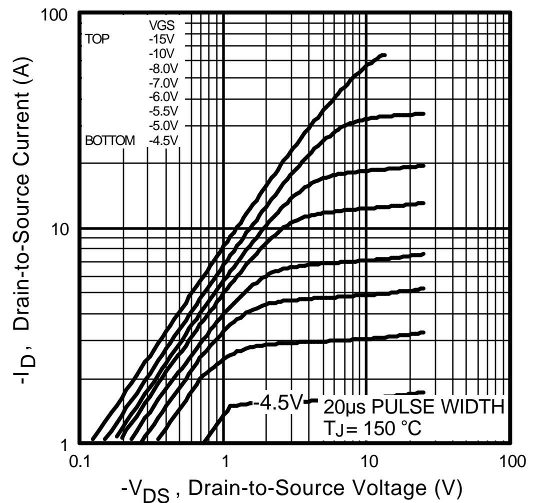


Fig 2. Typical Output Characteristics

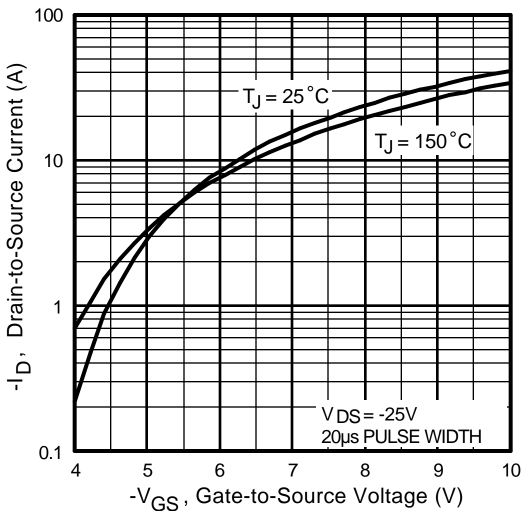


Fig 3. Typical Transfer Characteristics

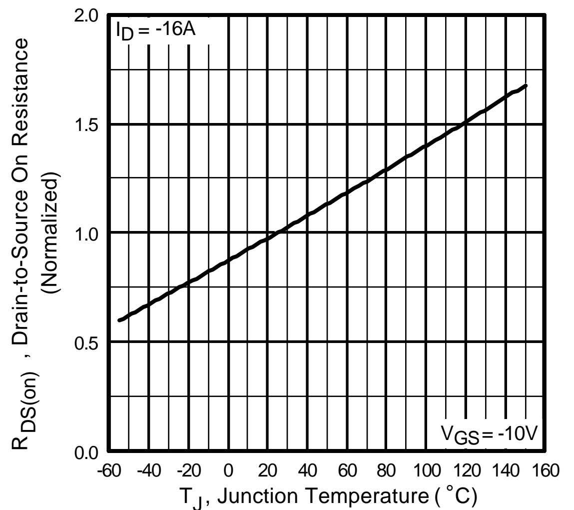


Fig 4. Normalized On-Resistance Vs. Temperature

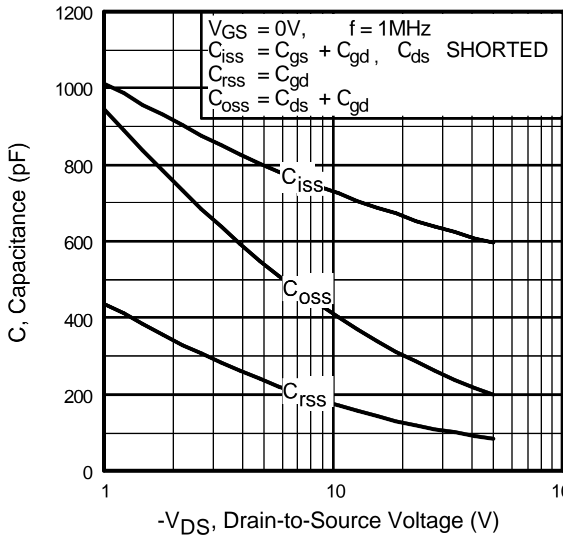


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

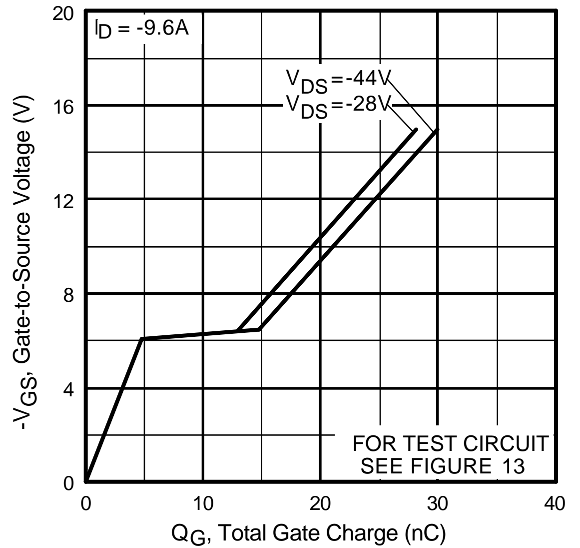


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

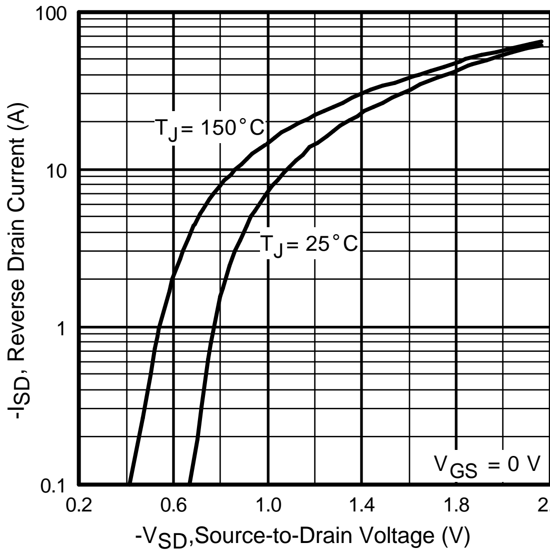


Fig 7. Typical Source-Drain Diode Forward Voltage

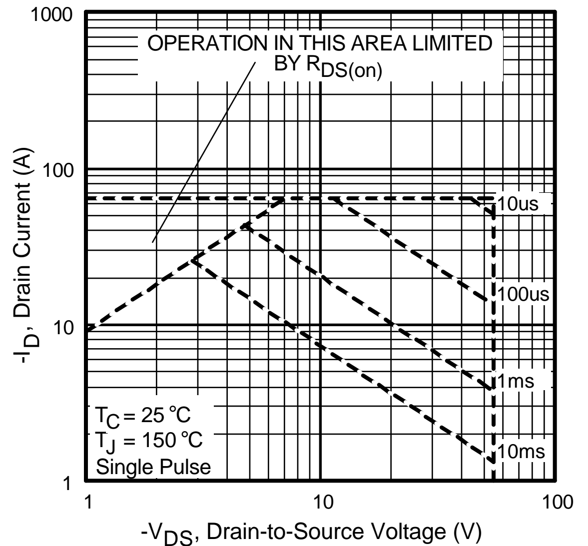


Fig 8. Maximum Safe Operating Area

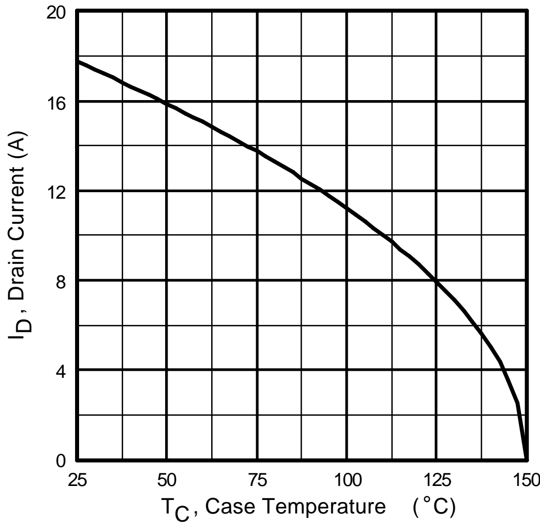


Fig 9. Maximum Drain Current Vs. Case Temperature

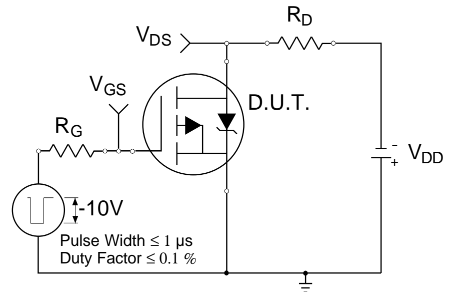


Fig 10a. Switching Time Test Circuit

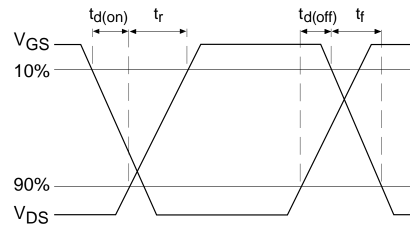


Fig 10b. Switching Time Waveforms

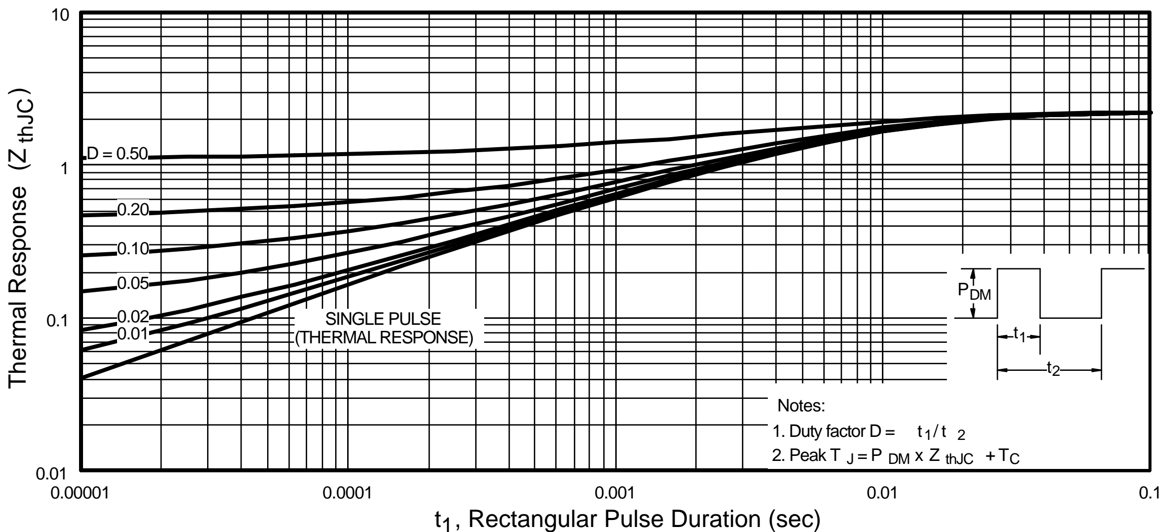


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

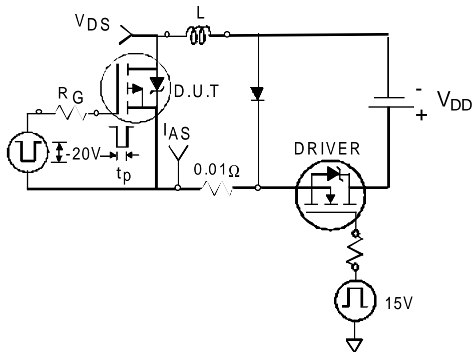


Fig 12a. Unclamped Inductive Test Circuit

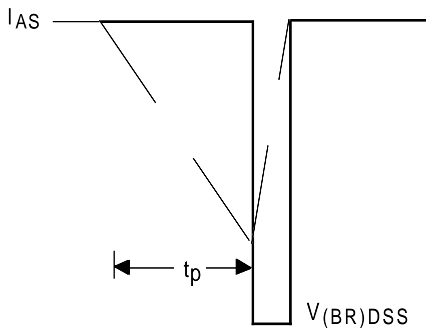


Fig 12b. Unclamped Inductive Waveforms

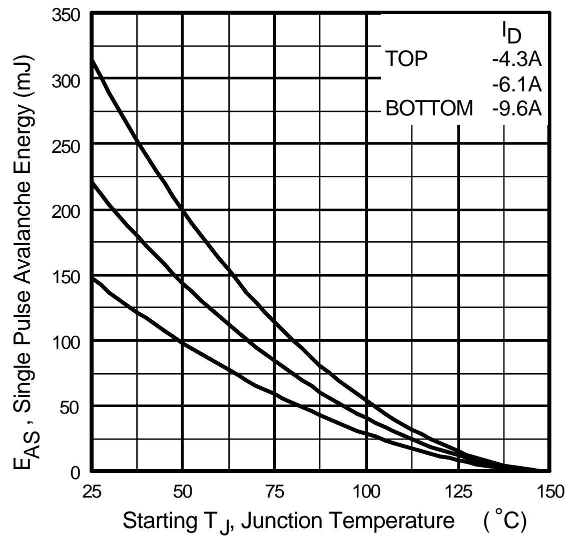


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

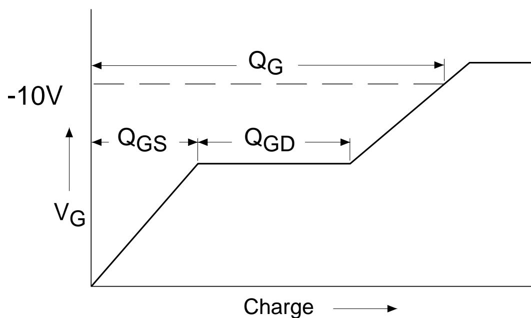


Fig 13a. Basic Gate Charge Waveform

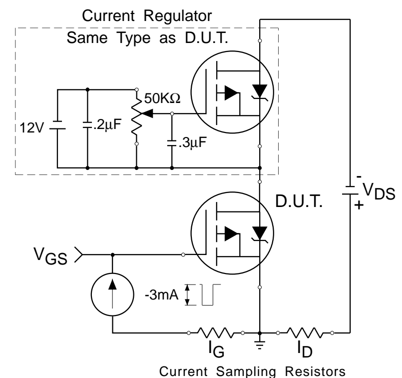
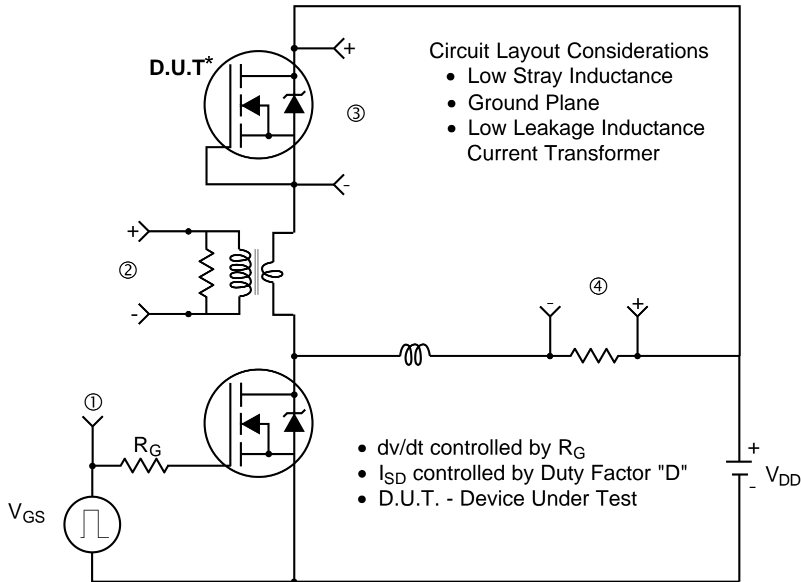
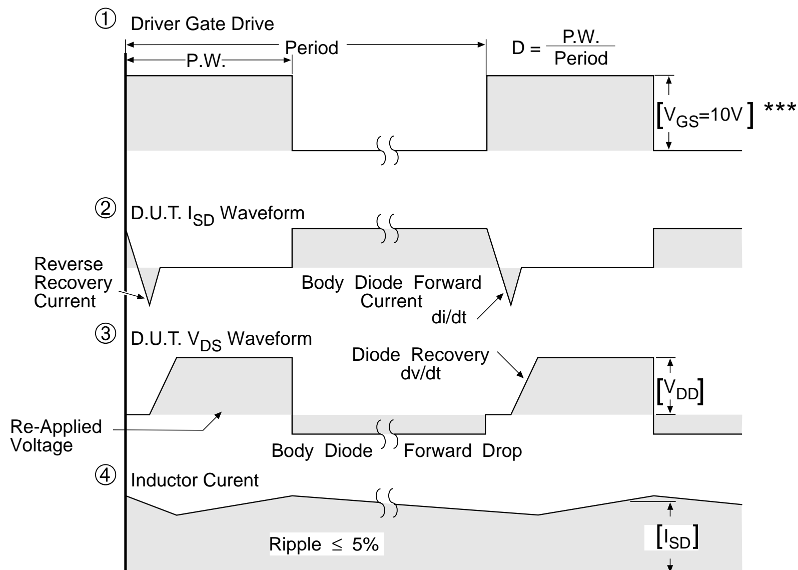


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



* Reverse Polarity of D.U.T for P-Channel

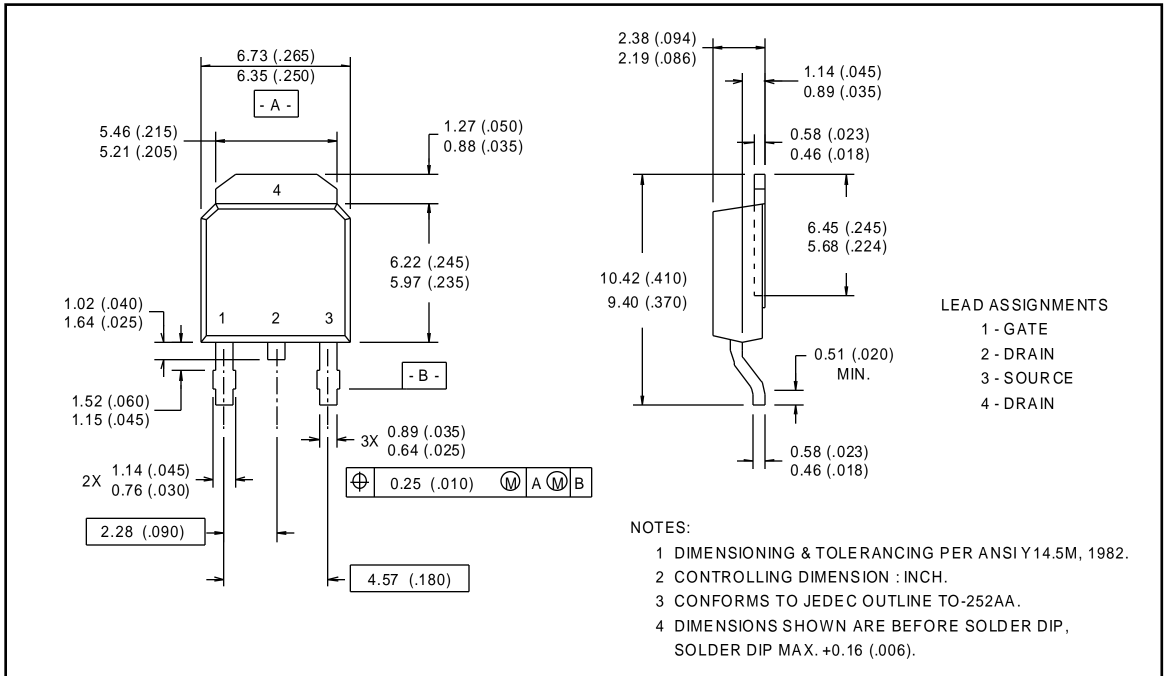


*** V_{GS} = 5.0V for Logic Level and 3V Drive Devices

Fig 14. For P-Channel HEXFETS

Package Outline

TO-252AA Outline
Dimensions are shown in millimeters (inches)



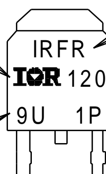
Part Marking Information

TO-252AA (D-Pak)

EXAMPLE : THIS IS AN IRFR120
WITH ASSEMBLY
LOT CODE 9U1P

INTERNATIONAL RECTIFIER LOGO

FIRST PORTION OF PART NUMBER



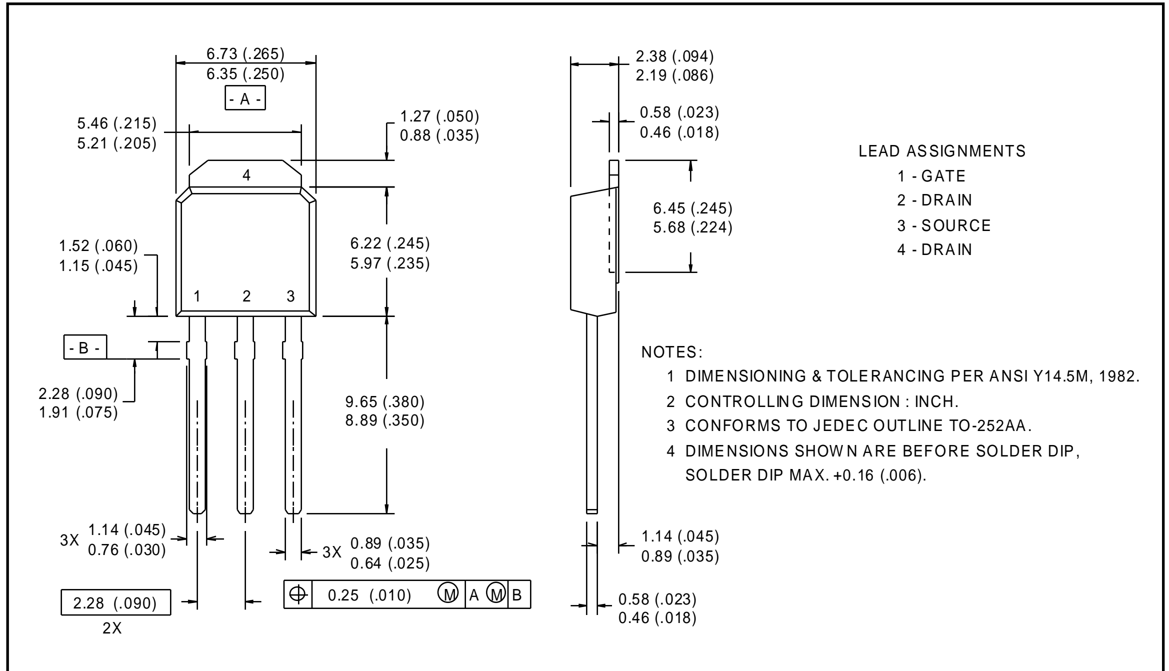
ASSEMBLY LOT CODE

SECOND PORTION OF PART NUMBER

Package Outline

TO-251AA Outline

Dimensions are shown in millimeters (inches)



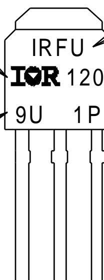
Part Marking Information

TO-251AA (I-Pak)

EXAMPLE : THIS IS AN IRFU120
WITH ASSEMBLY
LOT CODE 9U1P

INTERNATIONAL RECTIFIER LOGO

ASSEMBLY LOT CODE

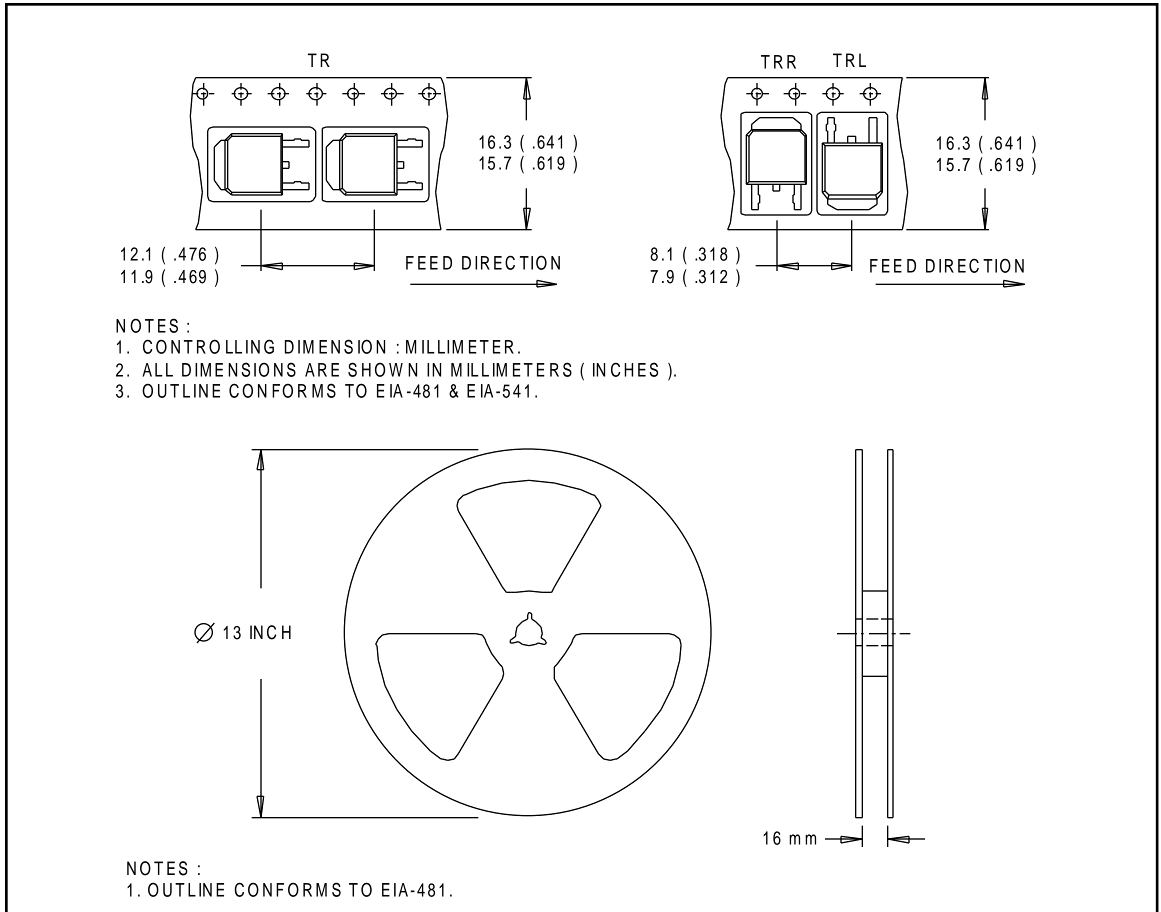


FIRST PORTION OF PART NUMBER

SECOND PORTION OF PART NUMBER

Tape & Reel Information

TO-252AA



International
IOR Rectifier

WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, Tel: (310) 322 3331
EUROPEAN HEADQUARTERS: Hurst Green, Oxted, Surrey RH8 9BB, UK Tel: ++ 44 1883 732020
IR CANADA: 7321 Victoria Park Ave., Suite 201, Markham, Ontario L3R 2Z8, Tel: (905) 475 1897
IR GERMANY: Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590
IR ITALY: Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111
IR FAR EAST: K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo Japan 171 Tel: 81 3 3983 0086
IR SOUTHEAST ASIA: 315 Outram Road, #10-02 Tan Boon Liat Building, Singapore 0316 Tel: 65 221 8371

Note: For the most current drawings please refer to the IR website at:
http://www.irf.com/package/